Product data sheet

## 1. Product profile

### 1.1 General description

Planar passivated sensitive gate four quadrant triac in a SOT223 (SC-73) surface-mountable plastic package intended for applications requiring enhanced immunity to noise and direct interfacing to logic level ICs and low power gate drivers.

### 1.2 Features and benefits

- Direct interfacing to logic level ICs
- Enhanced current surge capability
- Enhanced noise immunity
- High blocking voltage capability
- Sensitive gate triggering in all four quadrants
- Surface-mountable package

### 1.3 Applications

- General purpose low power motor control
- Home appliances

- Industrial process control
- Low power AC Fan controllers

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	-	600	V
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25$ °C; $t_p = 20$ ms; see Figure 4; see Figure 5	-	-	12.5	Α
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; T <sub>sp</sub> ≤ 103 °C; see <u>Figure 3</u> ; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	1	Α



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Table 1. Quick reference data ...continued

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
٥.	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G+;$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 9}}{ Company of the second of $	0.2	-	3	mA
		$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G-;$ $T_j = 25 ^{\circ}\text{C}; \text{ see } \frac{\text{Figure 9}}{\text{ Composition}}$	0.2	-	3	mA
		$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- \text{G-};$ $T_j = 25 ^{\circ}\text{C}; \text{ see } \frac{\text{Figure 9}}{\text{C}}$	0.2	-	3	mA
		$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- G+;$ $T_j = 25 ^{\circ}\text{C}; \text{ see } \frac{\text{Figure 9}}{\text{ Composition}}$	0.2	-	5	mA

## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T1	main terminal 1		N.I.
2	T2	main terminal 2	4	T2—
3	G	gate		`G sym051
4	T2	main terminal 2	1 2 3	
			SOT223 (SOT223)	

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
Z0103MN0	SOT223	plastic surface-mounted package with increased heatsink; 4 leads	SOT223

# 4. Marking

Table 4. Marking codes

Type number	Marking code <sup>[1]</sup>
Z0103MN0	103MN0

[1] % = placeholder for manufacturing site code

0103MN0

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# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	600	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; $T_{sp} \le 103 \text{ °C}$ ; see <u>Figure 3</u> ; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	1	Α
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25 \text{ °C}$ ; $t_p = 20 \text{ ms}$ ; see Figure 4; see Figure 5	-	12.5	Α
		full sine wave; $T_{j(init)} = 25 \text{ °C}$ ; $t_p = 16.7 \text{ ms}$	-	13.8	Α
I <sup>2</sup> t	I <sup>2</sup> t for fusing	$t_p = 10 \text{ ms; SIN}$	-	0.78	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_T = 1 \text{ A}; I_G = 20 \text{ mA};$ $dI_G/dt = 100 \text{ mA/}\mu\text{s}; T2+ G+$	-	50	A/µs
		$I_T = 1 \text{ A}$ ; $I_G = 20 \text{ mA}$ ; $dI_G/dt = 100 \text{ mA/}\mu\text{s}$ ; T2+ G-	-	50	A/µs
		$I_T = 1 \text{ A}; I_G = 20 \text{ mA};$ $dI_G/dt = 100 \text{ mA/}\mu\text{s}; T2- G-$	-	50	A/µs
		$I_T = 1 \text{ A}; I_G = 20 \text{ mA};$ $dI_G/dt = 100 \text{ mA/}\mu\text{s}; T2- G+$	-	20	A/µs
I <sub>GM</sub>	peak gate current		-	1	Α
$P_{GM}$	peak gate power		-	2	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	-	0.1	W
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	125	°C

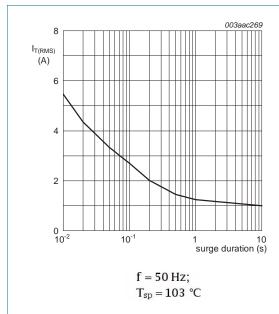


Fig 1. RMS on-state current as a function of surge duration; maximum values

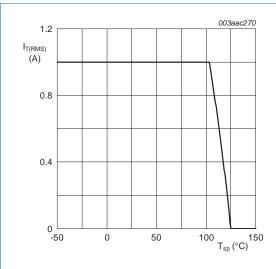


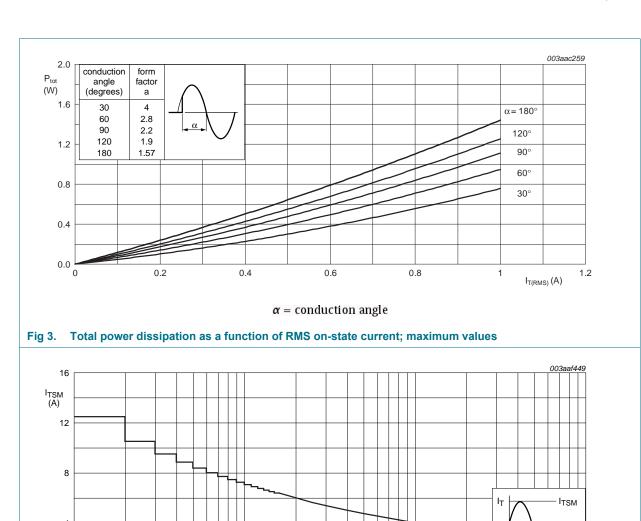
Fig 2. RMS on-state current as a function of solder point temperature; maximum values

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f = 50 Hz

 $10^{2}$ 

10

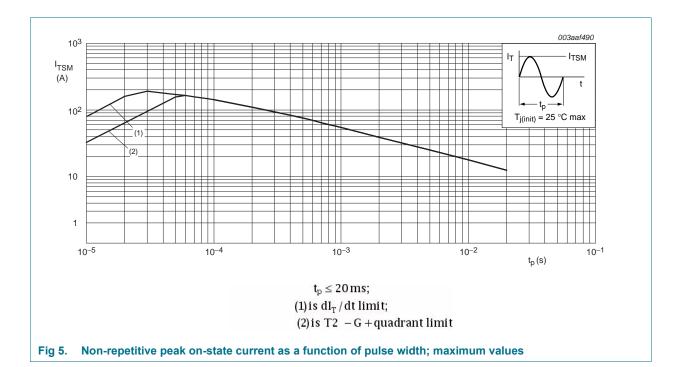
Fig 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

T<sub>j(init)</sub> = 25 °C max

number of cycles

10<sup>3</sup>

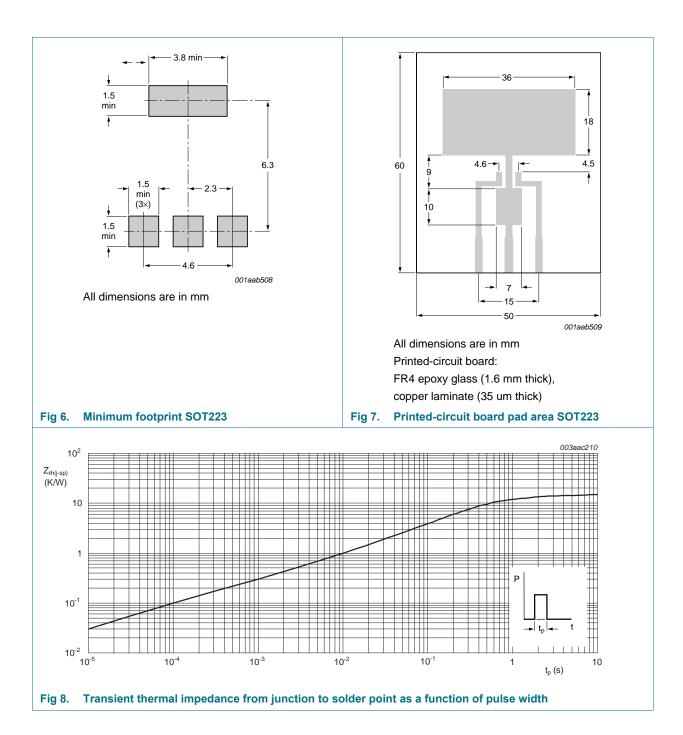
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## 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	full cycle; see Figure 8	-	-	15	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air; printed-circuit board mounted: minimum footprint; full cycle; see Figure 6	-	156	-	K/W
		in free air; printed-circuit board mounted: pad area; full cycle; see <u>Figure 7</u>	-	70	-	K/W



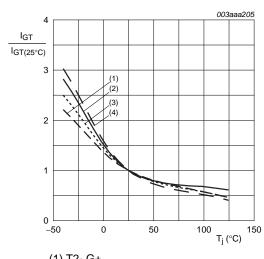
## 7. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 9}}{\text{ or } 100 \text{ Figure 9}}$	0.2	-	3	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G-;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 9}}{\text{ or } 100 \text{ c}}$	0.2	-	3	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- G-;} $ $T_j = 25 \text{ °C; see } \frac{\text{Figure 9}}{\text{ or } 100 \text{ m}}$	0.2	-	3	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- G+;} $ $T_j = 25 \text{ °C; see } \frac{\text{Figure 9}}{\text{ or } 100 \text{ c}}$	0.2	-	5	mA
IL	latching current	$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2 + G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 10}}{\text{ or } 10}$	-	-	7	mA
		$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2 + G-;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 10}}{\text{ II}}$	-	-	20	mA
		$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2\text{- }G\text{-};$ $T_j = 25 \text{ °C; see } \frac{\text{Figure } 10}{\text{ c}}$	-	-	7	mA
		$V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2\text{- }G\text{+;} $ $T_j = 25 ^{\circ}\text{C; see } \frac{\text{Figure } 10}{\text{ c}}$	-	-	7	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	-	7	mA
V <sub>T</sub>	on-state voltage	$I_T = 1 \text{ A}$ ; $T_j = 25 \text{ °C}$ ; see Figure 11	-	1.3	1.6	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T_j = 25 \text{ °C;}$ see Figure 12	-	-	1.3	V
		$V_D = 600 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 \text{ °C}$	0.2	-	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 600 V; T <sub>j</sub> = 125 °C	-	-	0.5	mA
Dynamic o	characteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 402 V; $T_j$ = 110 °C; gate open circuit; exponential waveform; see Figure 13	80	-	-	V/µs
dV <sub>com</sub> /dt	rate of change of commutating voltage	$V_D = 400 \text{ V}; T_j = 110 \text{ °C};$ $dI_{com}/dt = 0.44 \text{ A/ms}; \text{ gate open circuit}$	0.5	-	-	V/µs

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- (1) T2- G+
- (2) T2- G-
- (3) T2+ G-
- (4) T2+ G+

Normalized gate trigger current as a function of Fig 9. junction temperature

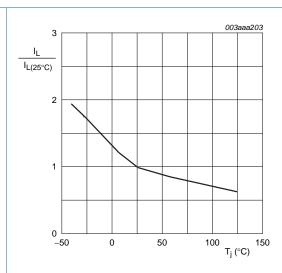
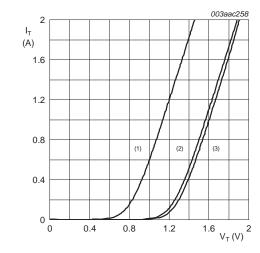


Fig 10. Normalized latching current as a function of junction temperature



 $V_0 = 1.254 \text{ V}$ 

 $R_s = 0.31 \Omega$ 

(1) T<sub>j</sub> = 125 °C; typical values

(2)  $T_j = 125$  °C; maximum values

(3) T<sub>i</sub> = 25 °C; maximum values

Fig 11. On-state current as a function of on-state voltage

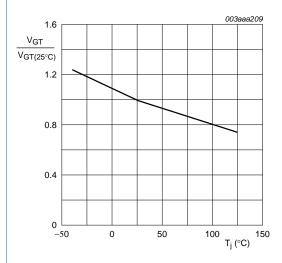


Fig 12. Normalized gate trigger voltage as a function of junction temperature

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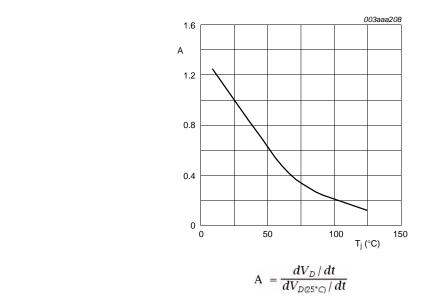


Fig 13. Normalized critical rate of rise of off-state voltage as a function of junction temperature; typical values

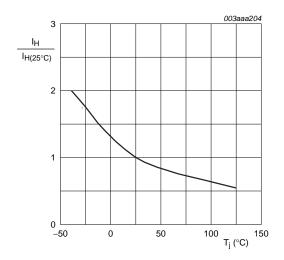


Fig 14. Normalized holding current as a function of junction temperature

## 8. Package outline

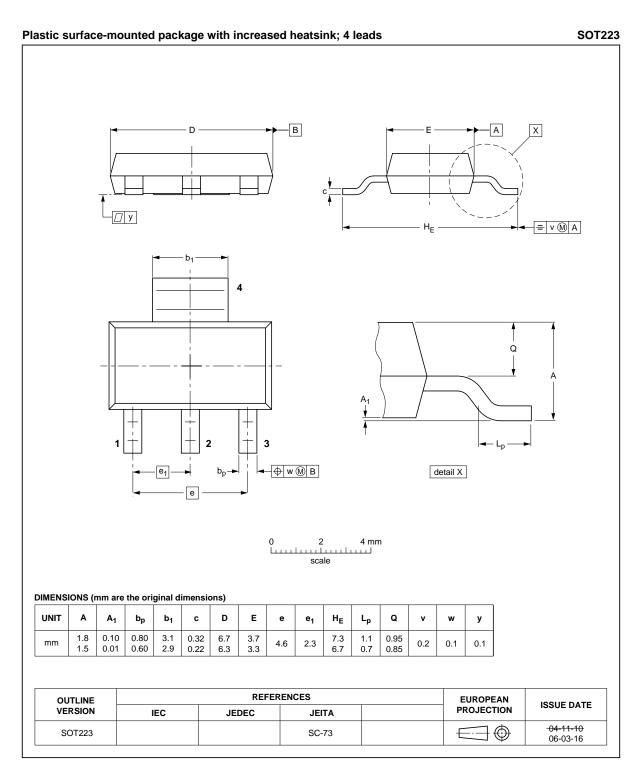
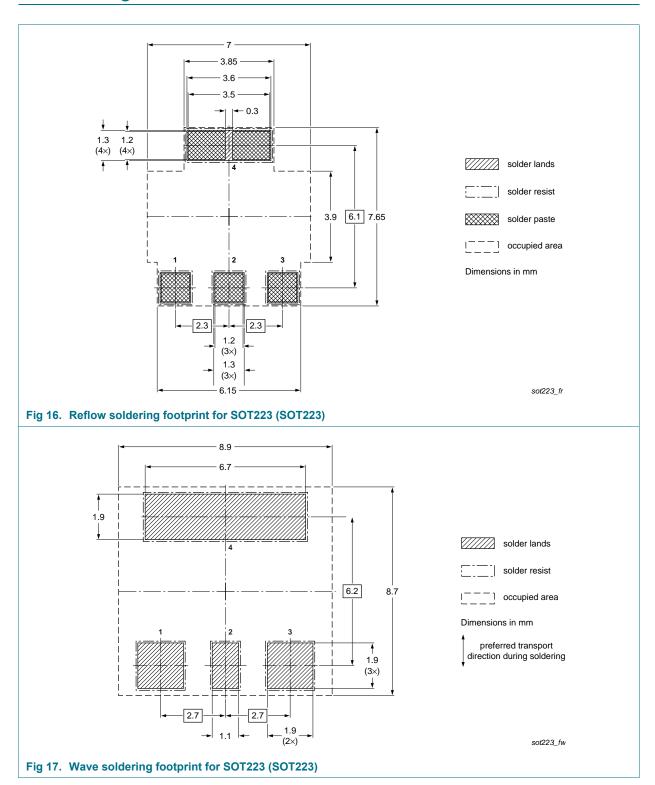


Fig 15. Package outline SOT223 (SOT223)

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# 9. Soldering



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# 10. Revision history

### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
Z0103MN0 v.1	20110103	Product data sheet	-	-

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## 11. Legal information

### 11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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